

INDIAN INSTITUTE OF INFORMATION TECHNOLOGY
DESIGN AND MANUFACTURING (IIITDM) KANCHEEPURAM

INTRODUCTION OF NEW COURSE

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| Course Title | Materials Fabrication and Characterization Techniques | Course No (to be assigned by Academic Cell) | PHY5XXX | | | |
| Specialization | Materials Science | Structure (LTPC) | 3 | 0 | 0 | 3 |
| To be offered for | UG / PG / Ph.D. | Status | Core <input type="checkbox"/> | Elective <input checked="" type="checkbox"/> | | |
| Faculty Proposing the course | Dr. Y. Ashok Kumar Reddy | Type | New <input checked="" type="checkbox"/> | Modification <input type="checkbox"/> | | |
| Date of DAC | 05/09/2018 | Members Present | All Faculty Members of the Dept. | | | |
| Pre-requisite | None | Submitted for approval | 38th Senate | | | |
| Learning Objectives | <ul style="list-style-type: none"> To know the deposition techniques for the manufacture of products To study the physical, morphological and chemical properties | | | | | |
| Learning Outcomes | <ul style="list-style-type: none"> This course aims to learn the different techniques to fabricate the device samples It can be mainly useful for PG, DD and as well as PhD students towards making the products and study the basic properties of the synthesized samples | | | | | |
| Contents of the course (With approximate break up of hours) | <p>I. Preparation of Thin Films</p> <p>A. Vacuum basics: (5) Production of Vacuum, Pressure measurement Gauges in Vacuum system</p> <p>B. Physical methods: (10) Thermal evaporation, Electron beam evaporation, Pulsed laser deposition and Molecular beam epitaxy. Sputtering: DC and RF sputtering, Glow discharge and Reactive magnetron sputtering.</p> <p>C: Chemical methods: (5) Atomic layer deposition, Chemical vapour deposition, Spray pyrolysis and Spin-coating.</p> <p>II. properties and Applications of Thin Films</p> <p>A. Characterization of thin films: (15) Crystallography Technique: X-Ray Diffraction. Imaging Techniques: Scanning electron microscopy, Transmission electron microscopy, Atomic force microscopy and Rutherford Backscattering Spectrometry. Spectroscopic Techniques: Energy Dispersive Spectroscopy, X-ray Photo electron Spectroscopy, Raman Spectroscopy, Secondary Ion Mass Spectrometry, Auger Electron Spectroscopy, UV-Vis-NIR Spectroscopy and Fourier Transform Infrared Spectroscopy.</p> <p>B. Applications of Thin Films: (7) Photolithography: Photoresists, Mask and pattern generation; Thin film capacitors, diodes and photodetectors; Thin film solar cells, Thin film micro-batteries; Thin film sensors: Gas sensors, Bolometers.</p> | | | | | |
| Text Books | <ol style="list-style-type: none"> Handbook of Thin Film Technology, <u>Hartmut Frey</u>, <u>H.R. Khan</u>, Springer, 1st ed. 2015. Materials Science of Thin Films: Deposition and Structure, <u>Milton Ohring</u>, <u>D. Gall</u>, <u>S. P. Baker</u>, Academic Press Inc, 3rd ed. 2014. | | | | | |
| Reference Books | <ol style="list-style-type: none"> Handbook of Thin Film Deposition, K. Seshan, D. Schepis, William Andrew, 4th ed. 2018. Surface Analysis Methods in Materials Science, J. O'Connor, B. Sexton, R.S.C. Smart, Springer-Verlag Berlin Heidelberg, 2nd ed. 2003. Materials Science of Thin Films: Deposition and Structure, <u>Milton Ohring</u>, <u>D. Gall</u>, <u>S.P. Baker</u>, Academic Press Inc, 3rd ed. 2014. | | | | | |